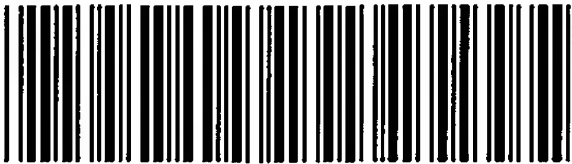


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/618,188	KANO, YOSHIKI	
	Examiner	Art Unit	
	Michael Krofcheck	2186	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search (EAST, PALM)	12/1/2005	MCK
NPL Search (IEEE) See attached search history	12/2/05	MCK
East (US-PAT, PGP-PUB, IBM-TDB) See attached search history	12/6/2005	MCK
711/111,112,114,161,162,165,4,6,202,203,206,207,221 707/204 Text search, see attached search history	12/6/2005	MCK